

## DMN2004VK-VB Datasheet

## Dual N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)max</sub> (Ω)	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
20	0.300 at V <sub>GS</sub> = 4.5 V	0.6			
	0.350 at V <sub>GS</sub> = 2.5 V	0.4	0.75		
	0.420 at V <sub>GS</sub> = 1.8 V	0.2	0.75		
	0.500 at V <sub>GS</sub> = 1.5 V	0.05			

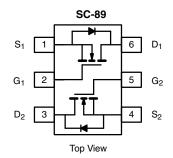
#### FEATURES

- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested



#### APPLICATIONS

- Load/Power Switching for Portable Devices
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories
- Battery Operated Systems
- Power Supply Converter Circuits



<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage		V <sub>GS</sub>	± 12	v	
Continuous Drain Current (T 150 °C)	T <sub>A</sub> = 25 °C	1-	0.60 <sup>a, b</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 70 °C	I D	0.49 <sup>a, b</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	2		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	۱ <sub>S</sub>	0.18 <sup>a, b</sup>	A	
Mariana Distriction	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.22 <sup>a, b</sup>	w	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 70 °C		0.14 <sup>a, b</sup>	VV	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient <sup>b</sup>	t ≤ 5 s	R <sub>thJA</sub>	470	565	°C/W	
Maximum Junction-to-Ambient-	Steady State	' 'thJA	560	675	0/11	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 5 s.

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	20			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		17		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 1.8		mv/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	0.4		1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 30	μΑ	
Callo Couros Lounago		$V_{DS} = 0 V, V_{GS} = \pm 4.5 V$			± 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μ, ι	
C C	'DSS	$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 85 ^{\circ}\text{C}$			3	1	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = \ge 5 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}$	2			A	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$		0.300			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 0.2 \text{ A}$		0.350		Ω	
	· DS(on)	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.2 A		0.420			
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 0.05 A		0.500			
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.5 A		7.5		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			43		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		14			
Reverse Transfer Capacitance	C <sub>rss</sub>			8			
Total Gate Charge	Qg	$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_{D} = 0.6 \text{ A}$		1.3	2	nC	
Total Gate Onlarge				0.75	1.2		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 0.6 \text{ A}$		0.15			
Gate-Drain Charge	Q <sub>gd</sub>			0.13		1	
Gate Resistance	R <sub>g</sub>	f = 1 MHz	2.4	12.2	24.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			11	20		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 20 $\Omega$		16	24	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 0.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, \text{ R}_g = 1 \Omega$		26	39		
Fall Time	t <sub>f</sub>			11	20		
Drain-Source Body Diode Characteris	tics						
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				2	А	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 0.5 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			10	15	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 0.5 A, dl/dt = 100 A/μs		2	4	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$_{\rm F} = 0.3  {\rm A},  {\rm div}{\rm dt} = 100  {\rm A}/{\rm \mu}{\rm S}$		5		ns	
Reverse Recovery Rise Time	t <sub>b</sub>	]		5		110	

Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

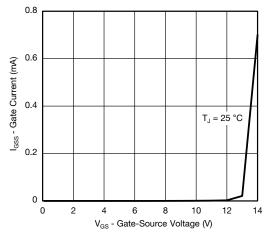
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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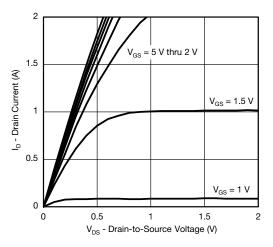
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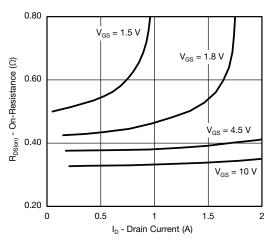
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



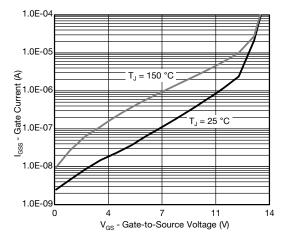




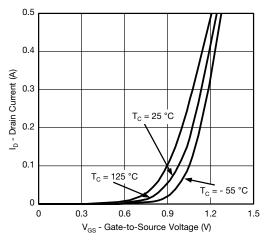




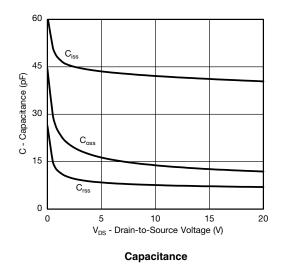
**On-Resistance vs. Drain Current** 



Gate Current vs. Gate-Source Voltage

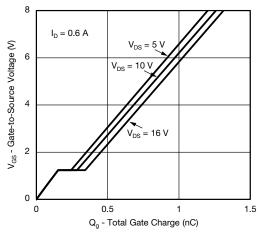


**Transfer Characteristics** 

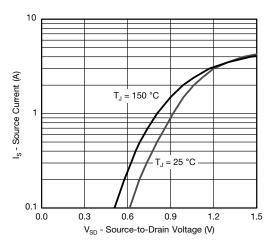




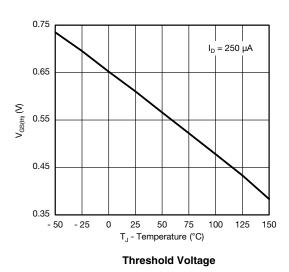
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Gate Charge

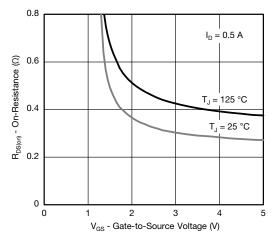


Soure-Drain Diode Forward Voltage

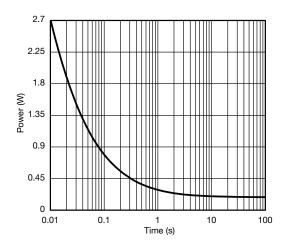


1.6  $I_{\rm D} = 0.5 ~{\rm A}$  $V_{GS} =$ 4.5 V R<sub>DS(on)</sub> - On-Resistance (Normalized) 1.4 1.2 1.0 0.8 = 2.5 V 'GS 0.6 - 50 - 25 0 25 50 75 100 125 150 T<sub>J</sub> - Junction Temperature (°C)

**On-Resistance vs. Junction Temperature** 

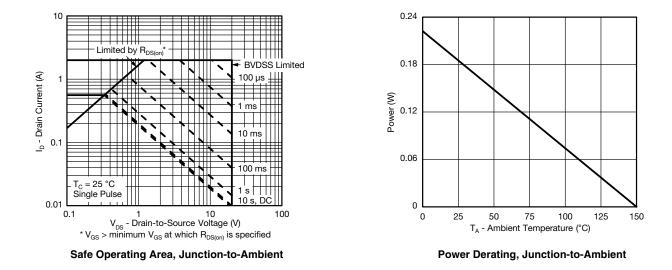


On-Resistance vs. Gate-to-Source Voltage



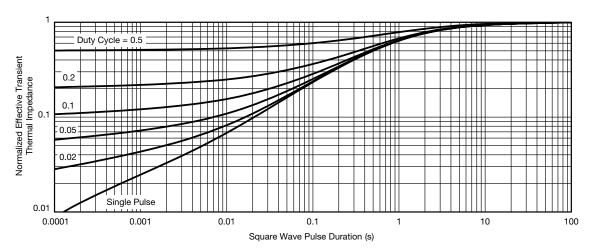
Single Pulse Power, Junction-to-Ambient





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

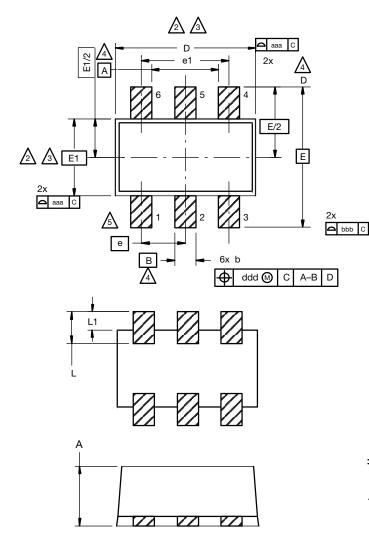
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Ambient

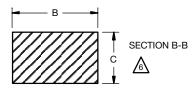


SC-89 6-Leads (SOT-563F)

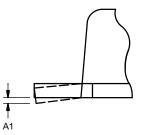


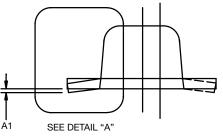
#### Notes

- 1. Dimensions in millimeters.
- Dimension D does not include mold flash, protrusions or gate burrs. Mold flush, protrusions or gate burrs shall not exceed 0.15 mm per dimension E1 does not include interlead flash or protrusion, interlead flash or protrusion shall not exceed 0.15 mm per side.
- 3. Dimensions D and E1 are determined at the outmost extremes of the plastic body exclusive of mold flash, the bar burrs, gate burrs and interlead flash, but including any mismatch between the top and the bottom of the plastic body.
- 4. Datums A, B and D to be determined 0.10 mm from the lead tip.
- 5. Terminal numbers are shown for reference only.
- 6. These dimensions apply to the flat section of the lead between 0.08 mm and 0.15 mm from the lead tip.





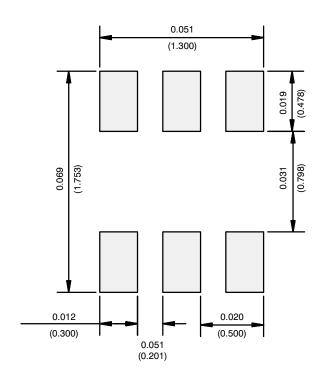




DIM.	MILLIMETERS				
	MIN.	NOM.	MAX.		
A	0.56	0.58	0.60		
A1	0	0.02	0.10		
b	0.15	0.22	0.30		
с	0.10	0.14	0.18		
D	1.50	1.60	1.70		
E	1.50	1.60	1.70		
E1	1.15	1.20	1.25		
е	0.45	0.50	0.55		
e1	0.95	1.00	1.05		
L	0.25	0.35	0.50		
L1	0.10	0.20	0.30		



#### **RECOMMENDED MINIMUM PADS FOR SC-89: 6-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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